ABSTRACT

The TPS65313-Q1 device is a power management integrated circuit (PMIC) for safety-relevant automotive applications with features supporting up to ASIL-C level. This device integrates a wide-input voltage off-battery buck regulator (BUCK1, 3.1-A rated), a low-voltage buck regulator (BUCK2, 2-A rated), and a 5-V boost converter (BOOST, 0.6-A rated). All the regulators are switching at 2.2-MHz and this device comes with a small package (40 pin QFN, 6-mm × 6-mm). This device also features an integrated adaptively randomized spread spectrum (ARSS) modulation for regulator switching clock to improve system level EMC performance.

This application report presents CISPR-25 Conducted Emission (CE) and Radiated Emission (RE) test results for the TPS65313-Q1 EVM and demonstrates how CISPR-25 class-5 limits can be met for this device.

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Schematics and Printed Circuit Board Description

1 Schematics and Printed Circuit Board Description

The TPS65313-EVM is designed with the purpose of passing the automotive-specific CISPR25 Class-5 Conducted and Radiated Emission tests. To improve the EMI performance of the device, an input filter is added to attenuate noise generated by the converter on the input voltage node. A snubber, together with a small boot resistor (between PHx and BOOTx pins), is added to the switching node of the device to attenuate high frequency components. Table 1 lists the device configuration used on the TPS65313-EVM for this testing. Figure 1 shows the VIN/VBAT filter used on the EVM for this testing. For detailed schematics and PCB layout information, refer to TPS65313-EVM User’s Guide.

Table 1. TPS65313-Q1 Device Configuration on EVM

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Value</th>
</tr>
</thead>
<tbody>
<tr>
<td>VIN / VBAT Input Voltage</td>
<td>12.5-V (Fully charged automotive battery)</td>
</tr>
<tr>
<td>VBUCK1 output voltage</td>
<td>3.3-V</td>
</tr>
<tr>
<td>VBUCK2 output voltage</td>
<td>1.8-V</td>
</tr>
<tr>
<td>VBOOST output voltage</td>
<td>5.0-V</td>
</tr>
<tr>
<td>Fsw Switching Frequency</td>
<td>2.2-MHz</td>
</tr>
<tr>
<td>Internal Spread spectrum mode</td>
<td>Enabled or disabled through the SPI interface</td>
</tr>
</tbody>
</table>

Figure 1. VIN/VBAT Filter Used on the TPS65313-EVM
2 Description of Test Setup

A fully compliant anechoic chamber and equipment is used for this testing and is carried out according to CISPR-25 test specifications. Two different TPS65313-EVM hardware BOM configurations (E2_1 and E2_7) is used for testing to study the impact of different external components on the EMC results. On each EVM, testing is done with and without spread spectrum enable options configured through SPI register settings.

**E2_1**: EVM without ferrite bead (L6, C79), without 3T capacitor (C80), without snubbers, without boot resistors. This is the base configuration without any external EMC measures with standard input supply filter.

**E2_7**: EVM with ferrite bead (L6) on VIN and VSUP2, with 100-nF 3T (C80) capacitor at VIN pin, with snubber (10-Ω, 1.2-nF snubber circuit used on each regulator), with boot resistors (10-Ω on each regulator boot pin).

For CE measurements, both line side (12-V battery positive side) and return side (12-V battery negative/ground side) measurements are done. Ambient measurements are done with the device in off state.

2.1 **Test Conditions:**

- **Input supply:**
  - Fully charged 12-V car battery.
  - Measured input supply current on E2_1 EVM = 505-mA.
  - Measured input supply current on E2_7 EVM = 545-mA.

- **Load on each regulators:**
  - BUCK1 = 5-Ω resistive load.
  - BUCK2 = 1.8-Ω resistive load and BOOST = 56-Ω resistive load.
  - Including BUCK2 and BOOST load, BUCK1 has around 1.5-A load current.

- **Table 2** shows EMI receiver settings for the conducted emission measurements.

<table>
<thead>
<tr>
<th>Frequency Range</th>
<th>Resolution Bandwidth</th>
<th>Step size</th>
<th>Measurement time</th>
</tr>
</thead>
<tbody>
<tr>
<td>150-kHz – 30-MHz</td>
<td>9-kHz</td>
<td>5-kHz</td>
<td>50-ms/Pts</td>
</tr>
<tr>
<td>30-MHz – 108-MHz</td>
<td>120-kHz</td>
<td>50-kHz</td>
<td>5-ms/Pts</td>
</tr>
</tbody>
</table>

- **Table 3** shows EMI receiver settings for Radiated Emission measurement.

<table>
<thead>
<tr>
<th>Frequency Range</th>
<th>Resolution Bandwidth</th>
<th>Step size</th>
<th>Measurement time</th>
</tr>
</thead>
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<td>50-ms/Pts</td>
</tr>
<tr>
<td>30-MHz – 200-MHz</td>
<td>120-kHz</td>
<td>50-kHz</td>
<td>5-ms/Pts</td>
</tr>
<tr>
<td>200-MHz – 1-GHz</td>
<td>120-kHz</td>
<td>50-kHz</td>
<td>5-ms/Pts</td>
</tr>
</tbody>
</table>
2.2 Test Setup Photos:

Figure 2. Test Setup for Conducted Emission Measurement

Figure 3. Test Setup for Radiated Emission Measurement: 150-kHz to 30-MHz (Monopole Rod Antenna)

Figure 4. Test Setup for Radiated Emission Measurement: 30-MHz to 200-MHz (Vertical Bicon Antenna)

Figure 5. Test Setup for Radiated Emission Measurement: 30-MHz to 200-MHz (Horizontal Bicon Antenna)

Figure 6. Test Setup for Radiated Emission Measurement: 200-MHz to 1000-MHz (Vertical Log Antenna)

Figure 7. Test Setup for Radiated Emission Measurement: 200-MHz to 1000-MHz (Horizontal Log Antenna)
2.3 **Pass or Fail Criteria**
1. Any peaks below the average limit are an automatic pass.
2. Any peaks above the peak limit are an automatic fail.
3. When the peak is below the peak limit and if the average is below the average limit, it is considered a pass.

3 **Test Results**

3.1 **Conducted Emission Results**

![Figure 8. CE – Ambient: Line Side](image1)

![Figure 9. CE – Ambient: Return Side](image2)

![Figure 10. CE Line Side: E2_1 EVM Variant](image3)

![Figure 11. CE Return Side: E2_1 EVM Variant](image4)

![Figure 12. CE Line Side: E2_7 EVM Variant](image5)

![Figure 13. CE Return Side: E2_7 EVM Variant](image6)
3.2 Radiated Emission (RE) – 150-KHz to 30-MHz, Rod Antenna

Figure 18. RE – 150-KHz to 30-MHz, Monopole Antenna: Ambient

Figure 19. RE – 150-KHz to 30-MHz, Monopole Antenna: E2_1 EVM Variant

Figure 20. RE – 150-KHz to 30-MHz, Monopole Antenna: E2_7 EVM Variant

Figure 21. RE – 150-KHz to 30-MHz, Monopole Antenna: E2_1 EVM Variant With SSM Enabled

Figure 22. RE – 150-KHz to 30-MHz, Monopole Antenna: E2_7 EVM Variant With SSM Enabled
### 3.3 Radiated Emission (RE) – 30-MHz to 200-MHz, Bicon Antenna Results

![Graph](image1)

**Figure 23.** RE – 30-MHz to 200-MHz, Bicon Vertical: Ambient

![Graph](image2)

**Figure 24.** RE – 30-MHz to 200-MHz, Bicon Horizontal: Ambient

![Graph](image3)

**Figure 25.** RE – 30-MHz to 200-MHz, Bicon Vertical: E2_1 EVM Variant

![Graph](image4)

**Figure 26.** RE – 30-MHz to 200-MHz, Bicon Vertical: E2_7 EVM Variant

![Graph](image5)

**Figure 27.** RE – 30-MHz to 200-MHz, Bicon Horizontal: E2_1 EVM Variant

![Graph](image6)

**Figure 28.** RE – 30-MHz to 200-MHz, Bicon Horizontal: E2_7 EVM Variant
Figure 29. RE – 30-MHz to 200-MHz, Bicon Vertical: E2_1 EVM Variant With SSM Enabled

Figure 30. RE – 30-MHz to 200-MHz, Bicon Vertical: E2_7 EVM Variant With SSM Enabled

Figure 31. RE – 30-MHz to 200-MHz, Bicon Horizontal: E2_1 EVM Variant With SSM Enabled

Figure 32. RE – 30-MHz to 200-MHz, Bicon Horizontal: E2_7 EVM Variant With SSM Enabled
3.4 Radiated Emission (RE) – 200-MHz to 1-GHz, Log antenna Results

Figure 33. RE – 200-MHz to 1-GHz, Log Vertical: Ambient

Figure 34. RE – 200-MHz to 1-GHz, Log Horizontal: Ambient

Figure 35. RE – 200-MHz to 1-GHz, Log Vertical: E2_1 EVM Variant

Figure 36. RE – 200-MHz to 1-GHz, Log Vertical: E2_7 EVM Variant

Figure 37. RE – 200-MHz to 1-GHz, Log Horizontal: E2_1 EVM Variant

Figure 38. RE – 200-MHz to 1-GHz, Log Horizontal: E2_7 EVM Variant
4 Conclusion

- On the E2_7 EVM Variant, with given test conditions, with EMC counter measures like snubber, Boot resistor and SSM enable, CISPR-25 class-5 limits are passing with > 3-dBuV/m margin.
- On the E2_1 EVM Variant, with given test conditions, without EMC counter measures like snubber, Boot resistor and SSM enable, CISPR-25 class-5 is marginally failing at certain spot frequencies. But CISPR-25, class-4 limits are passing with good margin.
- EMC results can vary considerably based on the PCB, BOM and application conditions and hence these results are just for the reference and TI does not give any guarantee on the EMC results. Customers should verify the EMC performance on their board and optimize it to fulfill their requirements.

5 References

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